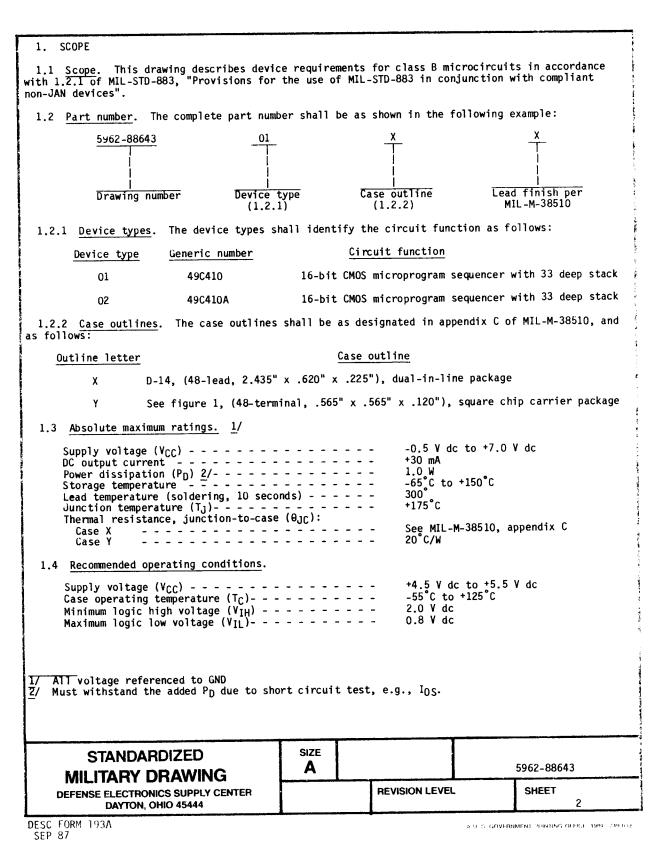
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| SHEET | | | | | | | | ļ | | _ | ↓_ | Ш | _ | | | | _ | <u></u> | L | | | | | <u> </u> | <u> </u> |
| REV | | 4 | | Ш | | | _ | ↓_ | _ | <u> </u> | ↓_ | \square | _ | Щ | | | _ | <u> </u> | - | _ | _ | <u> </u> | | | |
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| REV ST | | | V | | Α | | Α | _ | Α | ┞ | ┼ | Н | | Α | A | A | Α | ┡— | | Α | Α | Α | _ | ├ | <u> </u> |
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| D THIS DR | DRAWING THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS | | | | APPROVED BY William X. Hockman DRAWING APPROVAL DATE | | | | MICROCIRCUITS, DIGITAL, MICROPROGRAM SEQUENCER, SIZE CAGE CODE | | | ≀, M | , MONOLITHIC SILICON | | | | | | | | | | | | |
| AND DEPAR | AND AGENCIES OF THE DEPARTMENT OF DEFENSE AMSC N/A | | | | 1 AUGUST 1988 REVISION LEVEL A | | | | | | | 5962 -886 43 | | | | | | | | | | | | | |

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5962-E1773-3



2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

- Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103

- List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

REQUIREMENTS

- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
 - 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 2 herein.
 - 3.2.2 Instruction set. The instruction set shall be as specified on figure 3 herein.
 - 3.2.3 Logic diagram. The logic diagram shall be as specified on figure 4 herein.
 - 3.2.4 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
 - 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full case operating temperature range.
 - 3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
 - 3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

| STANDARDIZED MILITARY DRAWING | SIZE A | | | 5962-88643 | |
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| Test | Symbol | Con | ditions C < +125°C | Group A subgroups | | Limits | | Unit |
|---|-------------------|--|---|-----------------------------|---------------|--------------------|-------------------|-------------------|
| | | $V_{\rm CC} = 5$. | Ŏ V dc ±10% erwise specified | | | Min | Max | |
| High level output | I V _{OH} | $V_{11} = 0.8 V$ | I I _{OH} = -300 μA | 1,2,3 | A11 | 4.3 | | ٧ |
| | | VIH = 2.0 V | I _{OH} = -12 mA | | | 2.4 | | |
| Low level output | I V _{OL} | V _{CC} = 4.5 V V _{IL} = 0.8 V | I I _{OL} = 300 μA | 1,2,3 | A11 | | 0.2 | ٧ |
| | | V _{IH} = 2.0 V | I _{OL} = 20 mA | | | | 0.5 | Γ |
| High level input current | I I IH | V _{CC} = 5.5 V | , V _{IN} = 5.5 V | 1,2,3 | A11 | | 5.0 | μ Α |
| Low level input current | I IL | V _{CC} = 5.5 V | , V _{IN} = GND | 1,2,3 | A11 | | -5.0 | μ Α |
| Short circuit output current | 1 1 0S | V _{CC} = 4.5 V | , V _{OUT} = GND <u>1</u> / | 1,2,3 | A11 | -30 | | mA |
| Off state high impedance output | IIOZ | V _{CC} = 5.5 V | V _{OUT} = 0 V | 1,2,3 | A11 | | -10 | μ Α |
| current | | <u> </u> | V _{OUT} = 5.5 V | | | | 10 | |
| Quiesecent power supply current (CMOS inputs) | I CCQH | V _{CC} = 5.5 V V _{IH} > 5.3 V CP = H | $V_{IL} \leq 0.2 V,$ | 1,2,3 | All | - - - | 50 | mA |
| Quiesecent power supply current (CMOS inputs) | ICCQL | V _{CC} = 5.5 V V _{IH} > 5.3 V CP = L | , $V_{IL} \le 0.2 \text{ V}$, $f_{CP} = 0$, | 1,2,3 | A11 | - - - | 50 | |
| Quiesecent power supply current (TTL inputs) 2/ | Ісст | V _{CC} = 5.5 V f _{CP} = 0 | , V _{IN} = 3.4 V, | 1,2,3 | A11 | | | mA/ input |
| See footnotes at end o | | | SIZE | | 1 | | | |
| STANDAR MILITARY D | | | A | 5962-88643 | | | | |

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TABLE I. Electrical performance characteristics - Continued. Group A | Device Limits Unit Test Symbol Conditions -55°C < T_C < +125°C V_{CC} = 5.0 V dc ±10% |subgroups| type unless otherwise specified Min Max $\begin{array}{l} v_{CC} = 5.5 \text{ V, } v_{IL} \leq 0.2 \text{ V,} \\ v_{IH} = 5.3 \text{ V,} \\ \text{outputs open, } \overline{0E} = L \end{array}$ Dynamic power supply | I_{CCD} 1,2,3 A11 3.0 mA/MHz current $\begin{array}{l} \text{V}_{CC} = 5.5 \text{ V, } f_{CP} = 10 \text{ MHz,} \\ \text{outputs open,} \quad \text{V}_{IH} \geq 5.3 \text{ V,} \\ \text{V}_{IL} \leq 0.2 \text{ V, } \overline{0E} = \overline{L}, \\ \text{CP} = 50\% \text{ duty cycle} \\ \end{array}$ Total power supply 1,2,3 A11 80 mΑ ICC current 3/ $\begin{array}{l} \text{V}_{CC} = 5.5 \text{ V, } f_{CP} = 10 \text{ MHz,} \\ \text{outputs open, } \text{V}_{IH} = 3.4 \text{ V,} \\ \text{V}_{IL} = 0.4 \text{ V, } \overrightarrow{OE} = \text{L,} \\ \text{CP} = 50\% \text{ duty cycle} \end{array}$ 90 рF Input capacitance CIN See 4.3.1c 4 A11 12 15 рF COUT See 4.3.1c 4 A11 Output capacitance 7, 8 Functional test See 4.3.1d A11 lt_{S1} See figure 5 4/ 9,10,11 01 16 ns 02 7.0 See figure 5 9,10,11 01 30 ns 4/ ts2 15 02 ns 9,10,11 38 Setup time t_{S3} See figure 5 4/ 01 ns I_{0-3} 02 25 l ns See footnotes at end of table. STANDARDIZED SIZE Α 5962-88643 MILITARY DRAWING DEFENSE ELECTRONICS SUPPLY CENTER **REVISION LEVEL** SHEET DAYTON, OHIO 45444 5

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| Test | l Symbol | l | nditions Tc < +125°C | s | Group A Subgroups | Device type | Limits | | Unit |
|-----------------------------------|-----------------|---------------------|---|-------------|------------------------|----------------|------------------|--------------|--------|
| | | V _{CC} = 5 | $T_{\rm C}$ < $\pm 125^{\circ}{\rm C}$ 0.0 V dc $\pm 10^{\circ}{\rm C}$ therwise specific | ified | | , , | Min | Max | |
| Setup time | t _{S4} | See figure | 5 <u>4</u> / | | 9,10,11 | 01 | 35 |] | ns |
| | · | | | | | 02 | 18 | | ns |
| Setup time CCEN | t _{S5} | j ! ! | | - | 9,10,11 | 01 | 35 | | ns |
| | | | | - | | 02 | 18 | | l ns |
| Setup time CI | t _{S6} |] | | | 9,10,11 | 01 | 18 | | ns |
| | | | | | | 02 | 7.0 | | ns |
| Setup time | t _{S7} | | | 1 | 9,10,11 | 01 | 20 | | ns |
| | | i - | | | | 02 | 12 | ! | ns |
| Hold time D ₁ to R | t _{H1} | | | | 9,10,11 | 01 | 0 | | ns |
| | | - | | - | | 02 | 0 | | ns |
| Hold time D ₁ to PC | t _{H2} | | | ļ | 9,10,11 | 01 | 0 | <u> </u> | ns |
| | | | | | | 02 | 0 | <u> </u> | ns |
| See footnotes at | end of table. | | | | | | | | |
| | DARDIZED | | SIZE A | | | | 5962-8 | 8643 | |
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| Hold time | 1 | Cond -55°C < To V _{CC} = 5.0 unless othe | T _C < +125°C | subgroups | Device type | Limits | | Unit |
|---|------------------|--|-------------------------------|-----------|------------------|---------------|-------------|------|
| | | V _{CC} = 5 unless ot | .0 V dc ±10% herwise speci | fied | ! | Min | Max | |
| Hold time I _{O-3} | t _{H3} | See figure | 5 <u>4</u> / | 9,10,11 | 01 | 0 | | ns |
| | 1 | | | | 02 | 0 | | ns |
| Ho <u>ld</u> time | it _{H4} | | | 9,10,11 | 01 | 0 | | ns |
| | | | | | 02 | 0 | | ns |
| Hold time CCEN | t _{H5} | | | 9,10,11 | 01 | 0 | | ns |
| | | | | | 02 | 0 | | ns |
| Hold time CI | t _{H6} | | | 9,10,11 | 01 | 0 | | ns |
| | | | | | 02 | 0 | !]] | ns |
| Hold time | t _{H7} |] ! | | 9,10,11 | 01 | 0 | | ns |
| | | | | | 02 | 0 | | ns |
| Propagation delay D _{O-11} to Y | t _{PD1} |] | | 9,10,11 | 01 | 1 | 25 | ns |
| V 11 | | | | | 02 | | 15 | ns |
| ee footnotes at end | of table. | | | | | | | |
| STANDAI MILITARY I | | | SIZE A | | | 5962- | 88643 | |

| | Test | Symbol | _55°C / | nditions TC < +125°C | Group A subgroups | Device type | Limits | | Unit |
|--|--|------------------|----------------------|----------------------|----------------------|----------------|-----------|-------|--------------|
| 10-3 to Y 10-3 | | | | herwise specifie | d | | Min | Max | <u> </u> |
| Propagation delay tpp3 9,10,11 01 36 ns | | t _{PD2} | See figure | 5 <u>4</u> / | 9,10,11 | 01 | | 40 | ns |
| Description | | | 1 | | 1 | 02 | | 25 | ns |
| Propagation delay CCEN to Y 9,10,11 01 36 ns | Propagation delay CC to Y | t _{PD3} | | | 9,10,11 | 01 | | 36 | ns |
| Description | | | <u> </u> | | | ! 02 | | 20 | ns |
| Propagation delay CP to Y Propagation delay CP to Y Propagation delay OE to Y (enable) Propagation delay OE to Y (enable) Propagation delay OE to Y (disable) 5/ DE to Y (disable) STANDARDIZED SIZE | Propagation delay | t _{PD4} | ! | | 9,10,11 | 01 | | 36 | ns |
| Propagation delay (PD6 Propagation delay (PD6 Propagation delay (PD6 Propagation delay (PD7 Propagation delay (PD7 PD7 P | | | 1 | | | 02 | | 20 | ns |
| Propagation delay of the position of the posit | Propagation delay CP to Y | t _{PD5} | | | 9,10,11 | 01 | | 46 | ns |
| Propagation delay of to Y (enable) Propagation delay of to Y (disable) 5/ ee footnotes at end of table. STANDARDIZED SIZE | | | | | | 02 | | 33 | ns |
| Propagation delay of to Y (disable) 5/ 02 13 ns ee footnotes at end of table. STANDARDIZED SIZE | Propagation delay OE to Y (enable) | t _{PD6} | | | 9,10,11 | 01 | | 25 | ns |
| oE to Y (disable) 5/ 02 13 ns ee footnotes at end of table. STANDARDIZED SIZE | | | | | | 02 | | 13 | l ns |
| ee footnotes at end of table. STANDARDIZED SIZE | Propagation delay OE to Y (disable) | t _{PD7} | • i | | 9,10,11 | 01 | | 30 | ns |
| STANDARDIZED SIZE | | ! ! | | | | 02 | 1 | 13 | ns |
| SIANDARDIZED | ee footnotes at end | of table. | | | | | | | |
| | STANDARDIZED MILITARY DRAWING | | | | | | 5962- | 88643 | |

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| T <i>A</i> | ABLE I. E | lectrical performance character | ristics - (| Continued | l . | | |
|---|------------------|--|-----------------------------|--------------|---------------|---------------|--------------|
| Test | Symbol | Conditions -55°C < T _C < +125°C V _{CC} = 5.0 V dc ±10% | Group A subgroups | | Lim | Unit | |
| | | V _{CC} = 5.0 V dc ±10% unless otherwise specified | | | Min | Max |] |
| Propagation delay IO_3 to PL, VECT, MAP | t _{PD8} | See figure 5 4/ | 9,10,11 | 01 | 1 | 35 | ns |
| | | ! | | 02 | ! ! | 15 | ns |
| Propagation delay CP to FULL | t _{PD9} | | 9,10,11 | 01 | | 35 | l ns |
| | | | | 02 |]] | 25 | ns |
| Clock LOW time | tpw1 | | 9,10,11 | 01 | 25 | | ns |
| | |] - | | 02 | 20 | | l I ns |
| Clock HIGH time | tpw2 | | 9,10,11 | 01 | 25 | 1 | ns |
| | | | | 02 | 20 | | l ns |
| Clock period | i tp | | 9,10,11 | 01 | 51 | | ns |
| | | | | 02 | 40 | | ns |

^{1/} Not more than one output should be shorted at one time. Duration of the short circuit test should not exceed one second.

- I_{CCT} is derived by measuring the total current with all the inputs tied together at 3.4 V, subtracting out $I_{\text{CCQH}},$ then dividing by the total number of inputs.
- 3/ $I_{CC} = I_{CCQH}$ (CD_H) + I_{CCQL} (1 CD_H) + I_{CCT} (N_T X D_H) + I_{CCD} (f_{CP}).

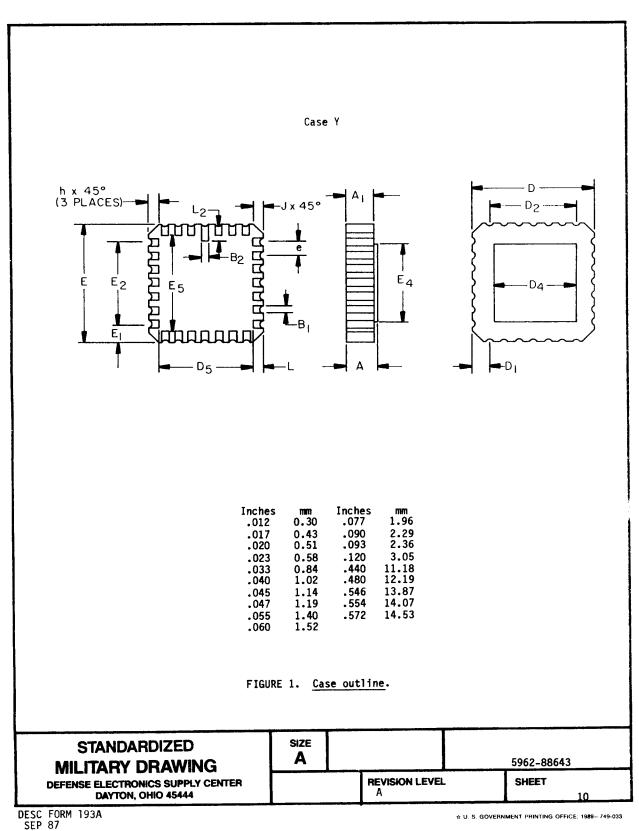
Where: CD_H = Clock duty cycle high period. D_H = Data duty cycle TTL high period (V_{IN} = 3.4 V). N_T = Number of dynamic inputs driven at TTL levels. f_{CP} = Clock input frequency.

- Unless otherwise specified, the input pulse level shall be between 0 V to 3.0 V, input rise/fall times shall be 1.0 V/ns and input and output timing reference levels shall be 1.5 V.
- 5/ Disable time is measured to 0.5 V change on output voltage level with C_L = 5 pF.

| STANDARDIZED MILITARY DRAWING | SIZE A | | 5962-88643 | |
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| Number of leads (N) | 48 | 3 | Number of leads (N) | 4 | 18 I |
|---------------------|-----------|-----------|--------------------------|---------------|--------|
| i | Min | Max | | Min | Max |
| A | .055 | .120 | E ₁ | .060 | REF |
| A ₁ | .045 | .090 | E2 | .440 | BSC |
| B ₁ | .017 | .023 | E4 | | .546 |
| B ₂ | .017 | .033 | E ₅ | .480 | REF |
| D D | .554 | 572 | e | .040 | BSC |
| D ₁ | .060 | REF | h | .012 | Radius |
| D ₂ | .440 | BSC | J | .020 | REF |
| D4 | | 1.546 | L | .033 | .047 |
| D ₅ | .480 | REF | L2 | .077 | .093 |
|] E | 1.554 | .572 | N N | 4 | 48 |
| 1 | | | l ND | | 12 |

ND = NE - Number of leads per side.

FIGURE 1. Case outline - Continued.

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| DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444 | | REVISION LEVEL A | SHEET |

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| Cases | X | and | Y |
|-------|---|-----|---|
| | | | _ |

| Pin number | Terminal connection | Pin number | Terminal connection |
|------------|---------------------|------------|---------------------|
| 1 | Y ₁₃ | 25 | D ₁₅ |
| 2 | D ₁₃ | 26 | Y ₁₅ |
| 3 | Y4 | 27 | D ₈ |
| 4 | D4 | 28 | Y8 |
| 5 | Y ₅ | 29 | Dg |
| 6 | D ₅ | 30 | Yg |
| 7 | VECT | 31 | D ₁₀ |
| 8 | PT | 32 | Y ₁₀ |
| 9 | MAP | 33 | D ₁₁ |
| 10 | I ₃ | 34 | Y ₁₁ |
| 11 | I ₂ | 35 | I DE |
| 12 | V _{3CC} | 36 | GND |
| 13 | I ₁ | 37 | СР |
| 14 | 10 | 38 | CI |
| 15 | CCEN | 39 | Yo |
| 16 | CC | 40 | D _O |
| 17 | RLD | 41 | Y ₁ |
| 18 | FULL | 42 | D ₁ |
| 19 | D ₆ | 43 | Y ₂ |
| 20 | Y ₆ | 44 | D ₂ |
| 21 | D ₇ | 45 | Υ3 |
| 22 | Y ₇ | 46 | D3 |
| 23 | D ₁₄ | 47 | Y ₁₂ |
| 24 | Y ₁₄ | 48 | D ₁₂ |

FIGURE 2. Terminal connections.

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MILITARY DRAWING
DEFENSE ELECTRONICS SUPPLY CENTER
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SIZE
A

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| 13-10 | Mnemonic | CC | Counter test | Stack | Address source | Register/ counter | Enable/ select |
|-------------------|---------------|----------------------|--|-------------------------------------|---------------------|--------------------------------|--|
| 0 | JZ | I X | Х | Clear | 0 | I NC | PC |
| 1 | CJS | Pass Fail | X X | Push NC | l D l Pc | NC NC | PL PL |
| 2 | JMAP | X | X | I I NC | l I D | I NC | MAP |
| 3 | CJP | Pass Fail | X X | NC NC | l D l Pc | I I NC I NC | <u>PL</u> <u>PL</u> |
| 4 | PUSH | Pass Fail | X X | Push Push | l Pc l Pc | Load NC | <u>PC</u> <u>PL</u> |
| 5 | JSRP | Pass Fail | X X | Push Push | D R | I I NC I NC | PL |
| 6 | CJV | Pass Fail | X X | I I NC I NC | l D l Pc | NC NC | VECT VECT |
| 7 | JRP | Pass Fail | X X | NC NC | D R | NC NC | PC PC |
| 8 | RFCT | X X | = 0 Not = 0 | l Pop NC | Pc Stack | I NC I DEC | PE PL |
| 9 | I RPCT | X X | = 0 Not = 0 | I I NC I NC | l Pc l D | NC DEC | PL |
| 10 | RPCT | Pass Fail | I X I X | Pop NC | Stack Pc | NC NC | PE PE |
| 11 | CJPP | Pass Fail |) X X | Pop NC | D Pc | NC NC | PC PL |
| 12 | LDCT | X | l X | I NC | Pc | Load | PC |
| 13 | LOOP | Pass Fail | X X | Pop NC | Pc Stack | I NC I NC | PL PL |
| 14 | CONT | l x | i X | l NC | l Pc | I NC | <u>PL</u> |
| 15 | TWB I I | Pass Pass Fail Fail | = 0 Not = 0 = 0 Not = 0 | Pop Pop Pop NC | Pc Pc Pc D D Stack | I NC I DEC I NC I DEC | <u>PC</u> <u>PL</u> <u>PC</u> <u>PL</u> |

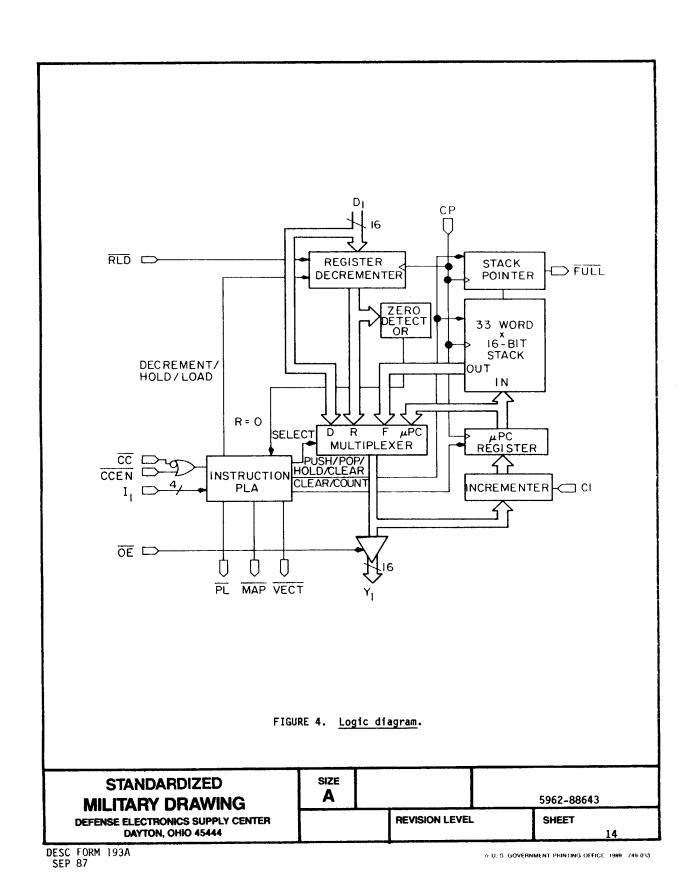
NC = No change; DEC = Decrement

FIGURE 3. <u>Instruction set</u>.

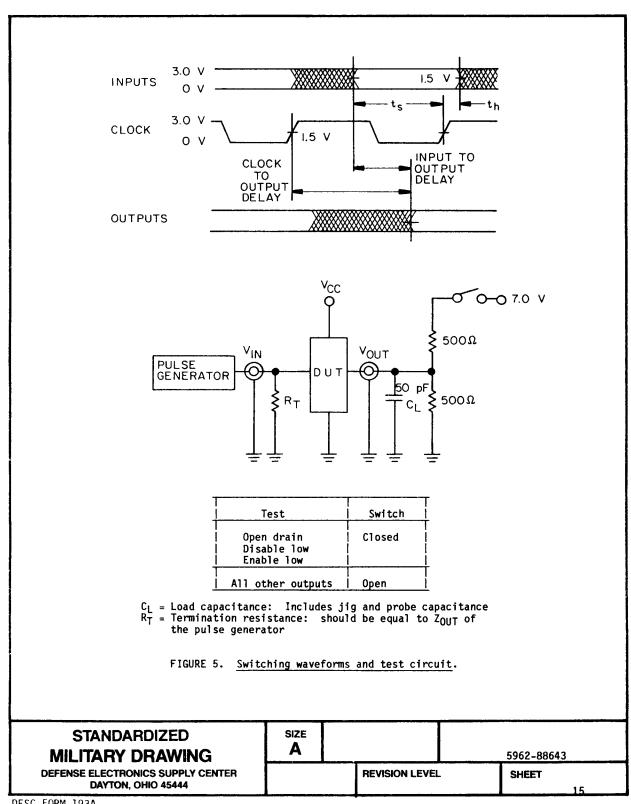
| STANDARDIZED MILITARY DRAWING | SIZE A | | 5962-88643 | | | |
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- 3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECC prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECC shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5 and 6 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Subgroup 4 ($C_{\rm IN}$ and $C_{\rm OUT}$ measurement) shall be measured only initially test and after process or design changes which may affect capacitance.
 - d. Subgroups 7 and 8 functional testing shall include the verification of instruction set.

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TABLE II. Electrical test requirements.

| MIL-STD-883 test requirements | Subgroups (per method 5005, table I) | | |
|--|--|--|--|
| Interim electrical parameters (method 5004) | | | |
| Final electrical test parameters (method 5004) | 1 1*, 2, 3, 7, 8, 9, 10, 11 | | |
| Group A test requirements (method 5005) | 1*, 2, 3, 4, 7, 8, 9, 10, 11 | | |
| Groups C and D end-point electrical parameters (method 5005) | 1, 2, 3, 7, 8 | | |

^{*} PDA applies to subgroup 1.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition D using the circuit submitted with the certificate of compliance (see $3.6 \, \text{herein}$).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

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- 6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using Dd Form 1693, Engineering Change Proposal (Short Form).
- 6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECC telephone (513) 296-6022.
- 6.5 Comments. Comments on this drawing should be directed to DESC-ECC, Dayton, Ohio 45444, or telephone (513) 296-8525.
- 6.6 Approved sources of supply. Approved sources of supply are listed in MIL-BUL-103. Additional sources will be added as they become available. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to DESC-ECC. The approved sources of supply listed below are for information purposes only and are current only to the date of the last action of this document.

| Military drawing part number | Vendor CAGE number | Vendor similar part number 1/ |
|---------------------------------|--------------------------------|---|
| 5962-8864301XX | 61772 | IDT49C410CB |
| 5962-8864301YX | 2/ | IDT49C410LB |
| 5962-8864302XX | 61772 | IDT49C41OACB |
| 5962-8864302YX | 2/ | IDT49C41OALB |

^{1/} Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

2/ Approved source of supply not available.

Vendor CAGE number Vendor name and address

61772

Integrated Device Technology Incorporated 1566 Moffett Boulevard

Salinas CA 93905

Point of contact: 3236 Scott Boulevard

Santa Clara CA 95054

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